

Search Notes

Application/Control No.

10/663,744

Examiner

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Applicant(s)/Patent under
Reexamination

HUAPAYA, LUIS

Art Unit

2173

SEARCHED

Class	Subclass	Date	Examiner
715	804	6/7/2007	KV
715	802	6/7/2007	KV

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East search (USPAT USPGPUB EPO JPO DERWENT IBM_TDB USOCR)	6/7/2007	KV